Applicant(s)/Patent Under Application/Control No. Reexamination 09/974,554 LINDQVIST ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 2134 Ellen C. Tran **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY 04-2006 Slik, David 709/201 US-7,028,071 B1 Α US-В US-С US-D US-Ε US-F US-G US-Н US-١ US-US-Κ US-US-М FOREIGN PATENT DOCUMENTS Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)

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